

10/519034 #2

PATENT
450100-05046

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IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicants: Yoshikazu TAKASHIMA et al.
International Application No.: PCT/JP04/004648
International Filing Date: March 31, 2004
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Sir:

Enclosed are copies of the publications, which were cited in the International

Search Report of International Application No. PCT/JP04/004648. Also enclosed is a copy of
Form PTO-1449 and the International Search Report.

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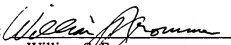
REMARKS

Entry of this Information Disclosure Statement and an early examination on the merits are respectfully solicited.

Please charge any additional fees to Deposit Account No. 50-0320.

Respectfully submitted,

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Enclosures

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Sheet 1 of 1

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	APPLICANT Yoshikazu TAKASHIMA et al.	
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LIST OF REFERENCES CITED BY APPLICANT
(Use several sheets if necessary)

U.S. PATENT DOCUMENTS

EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
	AA	5, 784, 528	07/21/98	Yamane et al.			
	AB						
	AC						
	AD						
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FOREIGN PATENT DOCUMENTS

EXAMINER INITIAL		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES NO
	AL	JP 2003-87742	03/20/03	Japan			
	AM	WO 97/13365	04/10/97	PCT			
	AN	EP 0 847,198	06/10/98	Europe			
	AO	JP 2003-18549	01/17/03	Japan			
	AP						

OTHER PRIOR ART (Including Author, Title, Date, Pertinent Pages, Etc.)

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